

# LEO Market Assessment for Crystal Oscillators

What is the Balance Point Between Commercial Off The **Shelf (COTS) and High-Reliability Space Oscillators for Low Earth Orbit Applications?** 



## **L-Series Low Earth Orbit Oscillators**

- **Designed and Constructed from Best performing Product Lines**
- **Commercial or Military Components**
- **Radiation Tolerant for Various LEO Mission Profiles**
- Analysis and Documentation Compromise Between COTS and S-Level
- All Oscillator Families Passed Qualification Testing for Total Ionized Dose (TID) and Single Event Latch-up (SEL) as a Completed, Functioning Oscillator
- **Designed, Assembled and Tested in Two Locations:** 
  - US Companies: Mount Holly Springs, PA, USA  $\bullet$

#### European Companies: Neckarbischofsheim, Germany $\bullet$

### **L-Series Requirements**

#### **Radiation:**

- **Total Ionized Dose (TID): 50krad**
- Single Event Latch-up (SEL): 42 MeV-cm2/mg

### **Reliability:**

**Commercial to Military Assembly and** Screening

#### Rating:

**Commercial or Military Grade Components** 

#### **Ruggedization:**

- **Designed and Constructed to Survive Launch** and Mission Profile
- **4-point Mount Crystals Except for XO**

| Assessment of Requirements for Mission Profiles |                   |                                      |  |                                    |  |
|---|-------------------|--------------------------------------|--|------------------------------------|--|
|   | Cube Satellites   | Commercial LEO<br>Constellations     | Exo Atmospheric Weapons                      | Launch Vehicles -<br>Rockets       |  |
| Orbit   | Low Earth         | Low Earth                            | Exo Atmospheric Ballistic<br>Trajectories    | None                               |  |
| Life Span                                       | 3 to 12 Months    | 5 to 10 Years                        | Unpowered 10 years                           | Unpowered 5 years                  |  |
| Total Ionized Dose                              | None              | 50 krad                              | None   | <1 krad                            |  |
| Single Event Latch-up                           | None              | 40MeV-cm2/mg                         | 60 MeV-cm2/mg                                | 60 Mev-cm^2/mg                     |  |
| Prompt Dose                                     | None              | None                                 | Yes  | Yes                                |  |
| Shock and Vibration                             | Survive Launch    | Survive Launch                       | Survive Launch and Mission<br>Profile        | Survive Launch                     |  |
| Temp Range                                      | -40°C to 85°C     | -40°C to 85°C                        | -55°C to 125°C                               | -40°C to 85°C                      |  |
| Screening Level                                 | Unscreened        | Class B- Screening +<br>Aging + PIND | Class B Screening + Group A +<br>PIND + XRAY | Class B Screening + PIND<br>+ XRAY |  |
| Component Grade                                 | COTS              | COTS                                 | Military                                     | COTS                               |  |
| Quartz  | Unswept           | Unswept                              | Swept  | Unswept                            |  |
|   |                   | 3-point Minimum                      |  | 3-point Minimum                    |  |
| Crystal Mount                                   | 2-point           | 2-point Mount 5 x7 or<br>Smaller     | 4-point                                      | 2-point Mount 5 x7 or<br>Smaller   |  |
| g-Sensitivity                                   | No                | No                                   | Yes  | Yes                                |  |
| Recommended Design<br>and Construction          | Ruggedized        | Ruggedized                           | Ruggedized                                   | Ruggedized                         |  |
| Additional Options for Reliability Confidence   |                   |                                      |  |                                    |  |
| Optional: Worst                                 | Case Circuit Anal | ysis to Account for T                | hermal and Datasheet E                       | Electrical Variations              |  |

Swept Quartz to Minimize TID Effects



Optional: Final Electrical Test Data Packet for Traceability

Optional: MTBF Analysis and Report Tailored to Environment and Temperature

| High Reliability vs COTS Compromise   | Commercial  | <b>L-Series</b>  | <b>High Reliability</b>  |
|---|---|--|--|
| The need for economically priced oscillators for low earth orbit applications   | No Flight Heritage  | No Flight Heritage   | Multiple Decades of Flight Heritage  |
| reliability world. The comfortable, although exhausting, position of ensuring<br>every electrical and mechanical design, material, construction, layout,  | Limited Component Traceability                                      | Limited Traceability With Data Packet  | Full Traceability with Operator Dated and Signed<br>Travelers                        |
| inspection, and many, many others are screened and evaluated to the<br>highest levels possible, to ensure the lowest probability of failure over a<br>shorter mission life, lower radiation requirements and lower cost.              | Non-Homogeneous Lots  | Non-Homogeneous Lots   | Homogeneous Lots with Single Lot Date Codes  |
| Commercial datasheets provide limits to component values but do not<br>address lot to lot variation, visually scrutinize the construction, eliminate<br>weaker parts electrically by overvoltage testing, reverse biasing, or burn-in | No Element Evaluation or Radiation Lot<br>Acceptance Testing (RLAT) | COTS or Class B Elements and Total Dose and<br>Single Event Latch-up Platform Validation | Class K Element Evaluation per MIL-PRF-38534 and<br>100krad+ Wafer Lot Specific RLAT |
| testing, or evaluate robustness for environmental effects such as shock and<br>vibration, constant acceleration, or temperature changes. This is called<br>"element evaluation" and is commonplace for high reliability designs and   | Few, if any, QA Visual Inspections                                  | Few, if any, QA Visual Inspections   | Multi-Point QA and Source Inspections at High<br>Magnification                       |
| completed well before construction takes place.<br>Printed circuit boards, substrates, enclosures, lids, terminals, and all other<br>mechanical items are also scrutinized for materials, plating, dimensions, a                      | Data Electronically Stored  | Data Pack optional   | Data Electronically Stored with Printed Data Pack<br>and Review Provided             |
| many others.<br>Engineers want as much confidence as they can get from commercial parts<br>and screening because they cannot afford the cost and timeframe required   | Basic Circuit Analysis Performed                                    | MTBF, Electrical and Thermal WCCA<br>Performed   | WCCA Electrical, Derating, Thermal, Mechanical,<br>Radiation, and Others             |
| for more extensively vetted high reliability designs. They are relegated to<br>performing more analyses, reducing mission life, adding circuit<br>redundancies, or additional radiation shielding to improve the probability for      | Unswept Quartz  | Swept Quartz   | Swept Quartz   |
| mission success. The balance point is somewhere between the two   | 2 or 3-point Crystal Mount  | 4-point Crystal Mount on all except XO   | 4-point Crystal Mount  |
| extremes.   | <b>Best Commercial Assembly Practices</b>                           | Best Commercial Assembly Practices   | QA Assurance per MIL-PRF-55310 Class-S<br>and MIL-PRF-38534 Class-K                  |